

<b>Notice of References Cited</b>	Application/Control No. 09/651,288	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	EP 0,361,471	04/1990	E.P	Inoue et al	*****
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**NON-PATENT DOCUMENTS**

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